

Search Notes

Application/Control No.

10/729,338

Examiner

JOHN J. LEE

Applicant(s)/Patent under
Reexamination

BAKER ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	11.1,522 127.2,7 223.1,10 9,442	6/11/2008	J.L
455	13.4,69	6/11/2008	J.L
455	15,67.11	6/11/2008	J.L
455	20,21	6/11/2008	J.L
370	332,218	6/11/2008	J.L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/11/2008	J.L